# MSKSEMI 美森科







TVC



TSS



MOV



GDT



PIFF

## MLXS0104LEX

Product specification





## Description

This 4-bit non-inverting translator is a bidirectional voltage-level translator and can be used to build digital switching compatibility between multi voltage systems. It uses two separate configurable power supply rails that including A ports supporting operating voltages from 1.65 V to 3.6 V with tracking V<sub>CCA</sub> supply, and also including B ports supporting operating voltages from 2.3 V to 5.5 V with tracking V<sub>CCB</sub> supply.

The advantage above provides the support of both lower and higher logic signal levels while providing bidirectional translation capabilities between any of the 1.8-V, 2.5-V, 3.3-V, and 5- V voltage circuit points.

Placing output-enable (OE) input to low level, all I/Os are forced to high-impedance state that significantly lower the quiescent current consumption. In order to ensure the high-impedance state during power up or power down, OE pin should be tied to GND via a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

#### **Features**

- No direction -control
- Data rates24 Mbps (Push Pull)2 Mbps (Open)
- 1.65 V to 3.6 V on A port and 2.3 V to 5.5 V on B port (Vcca ≤ VccB)
- VCC isolation feature: If either VCC input is at GND, both ports are in the high -impedance state
- No power -supply sequencing required:
   either VccA or V ccB can be ramped first
- loff supports partial -power -down mode operation
- Operating temperature range: -40°C to +85°C

## **Applications**

- Handset/Smartphone
- MART

- IPC
- GPIO

#### **Reference News**

TSSOP-14	Pinning and Package		Marking
	VccA	View  14	LXS01 04LEX • MS***

#### Order information

Orderable Device	Package	Packing Option
MLXS0104LEX	TSSOP-14	2000PCS

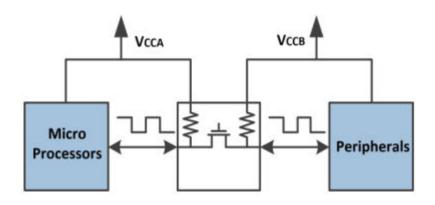


## **Device Summary, Pin and Packages (Continued)**

	F	Pin			
Name	RGY	D	PW	I/O	Function
Vcca	1	12	1	-	Port Supply Voltage. 1.65V≤VccA≤3.6V and VccA≤VccB
A1	2	1	2	I/O	Input/Output A1. Referenced to Vcca.
A2	3	2	3	I/O	Input/Output A2. Referenced to Vcca.
A3	4	3	4	I/O	Input/Output A3. Referenced to Vcca.
A4	5	4	5	I/O	Input/Output A4. Referenced to Vcca.
NC	6	-	6	-	No internal connection
GND	7	5	7	-	Ground
OE	8	6	8	I	Output Enable(Active High).Pull OE low to place all outputs in 3-state mode. Referenced to $V_{\text{CCA.}}$
NC	9	-	9	-	No internal connection
B4	10	7	10	I/O	Input/Output B4. Referenced to Vccb.
В3	11	8	11	I/O	Input/Output B3. Referenced to Vccb.
B2	12	9	12	I/O	Input/Output B2. Referenced to Vccb.
B1	13	10	13	I/O	Input/Output B1. Referenced to Vccb.
Vссв	14	11	14	-	B Port Supply Voltage. 2.3V≤VccB≤5.5V



## **Circuit Diagram**



## **Absolute Maximum Ratings**

Parameters	Min	Max	Unit	
Supply voltage, Vcca	Supply voltage, Vcca			
Supply voltage, Vссв	-0.3	6.0	V	
Input voltage range,Vi	A port	-0.3	6.0	V
input voitage range, vi	B port	-0.3	6.0	1 '
Voltage range applied to any output in the high-impedance or	A port	-0.3	6.0	V
power-off state, Vo	B port	-0.3	6.0	1 '
Voltage range applied to any output in the high or low state, Vo	A port	-0.3	V <sub>CCA</sub> +0.3	V
voltage range applied to any output in the high of low state, vo	B port	-0.3	V <sub>CCA</sub> +0.3	] <b>'</b>
Input clamp current,I <sub>IK</sub>	V <sub>I</sub> <0		-50	mA
Output clamp current,loк	V <sub>o</sub> <0		-50	mA
Continuous output current,lo			±50	mA
Continuous current through Vcca, Vccbor GND	Continuous current through Vcca, VccBor GND			
Maximum junction temperature			150	°C
Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

## **ESD Ratings**

	ESI	Value	Unit	
V(ESD)	Electrostatic Discharge	Human-Body Model (HBM) <sup>(1)</sup>	±3K	V
		Charged-Device Model (CDM) <sup>(2)</sup>	±2K	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed

<sup>(3)</sup> The value of Vcca and Vccb are provided in the recommended operating conditions table.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## **Recommended Operating Conditions**

Vccı is the supply voltage associated with the input port. Vcco is the supply Voltage associated with the output port.

Parameter	C	Conditions	Min	Тур	Max	Unit	
Supply voltage (1)		V <sub>CCA</sub>			3.6	V	
Supply Vollage		$V_{CCB}$	2.3		5.5	V	
	A-port I/Os	V <sub>CCA</sub> =1.65 V to 1.95 V V <sub>CCB</sub> =2.3 V to 5.5 V	Vcci-0.2		Vccı		
High-level	7 Cpoil ii Co	V <sub>CCA</sub> =2.3 V to 3.6 V V <sub>CCB</sub> =2.3 V to 5.5 V	Vcci-0.4		Vccı	V	
input voltage(Vін)	B-port I/Os	V <sub>CCA</sub> =1.65 V to 3.6V V <sub>CCB</sub> =2.3 V to 5.5 V	Vcci-0.4		Vccı	V	
	OE input	V <sub>CCA</sub> =1.65 V to 3.6 V V <sub>CCB</sub> =2.3 V to 5.5 V	V <sub>CCI</sub> ×0.8		5.5		
Low-level	A-port I/Os	V <sub>CCA</sub> =1.65 V to 1.95 V V <sub>CCB</sub> =2.3 V to 5.5 V	0		0.15	V	
input voltage(VIL) <sup>(2)</sup>	B-port I/Os	V <sub>CCA=</sub> 1.65 V to 3.6 V V <sub>CCB</sub> =2.3 V to 5.5 V	0		0.15		
OE	OE input	V <sub>CCA</sub> =1.65 V to 3.6 V V <sub>CCB</sub> =2.3 V to 5.5 V	0		Vcca ×0.25	V	
Input transition rise or	A-port I/Os	push-pull driving			10		
fall rate(Δt/Δv)	B-port I/Os push-pull driving				10	ns/V	
	Co	Control input			10		
TA Operating free- air temperature		-	-40		85	°C	

<sup>(1)</sup> Vcca must be less than or equal to Vccb.

 $<sup>(2) \</sup> The \ maximum \ V_{\text{IL}} \ value \ is \ provided \ to \ ensure \ that \ a \ valid \ V_{\text{OL}} \ \ is \ maintained. \ The \ V_{\text{OL}} \ \ value \ is \ V_{\text{IL}} \ \ plus \ the \ voltage \ drop \ across \ the \ pass \ gate \ transistor.$ 



### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)  $^{(1)(2)(3)}$ 

Pa	rameter	Conditions	VCCA	Vссв	Temp	Min	Тур	Max	Uni		
Vона	PortA Output High Voltage	lo <sub>H</sub> =-20 μA V <sub>IB</sub> ≥ V <sub>CCB</sub> - 0.4V	1.65V to 3.6V	2.3V to 5.5V	Full	Vcca×0.7			V		
Vola	PortA Output Low Voltage	lo∟=1mA Viв≤0.15 V	1.65V to 3.6V	2.3V to 5.5V	Full			0.3	V		
Vонв	Port B Output High Voltage	loh=-20 μA Via ≥ Vcca - 0.4V	1.65V to 3.6V	2.3V to 5.5V	Full	Vcca ×0.7			V		
V <sub>OLB</sub>	Port B Output Low Voltage	bl=1mA Via ≤ 0.15 V	1.65V to 3.6V	2.3V to 5.5V	Full			0.3	V		
ı	Input Leakage	OE	1.65V to 3.6V	2.3V to 5.5V	<b>+25</b> ℃			±1	μΑ		
'	Current	OL.	1.037 10 3.07	2.50 10 5.50	Full			±1.5	μΑ		
		A Ports	0V	0V to 5.5V	<b>+25</b> ℃			±0.5			
loff	Partial Power	ATOIS	OV.	0 1 10 3.5 4	Full			±1	μA		
	Down Current	B Ports	0V to 3.6V	0V	<b>+25</b> ℃			±0.5			
		D 1 0.10	0 10 0.01		Full			±1	I		
loz	High-impedance State Output	A or B port	1.65V to 3.6V	2.3V to 5.5V	<b>+25</b> ℃			±0.5	).5 μΑ		
NZ	Current		OE=0V 1.03V to 3.0V 2.3V to 3.3V		Full			±1	μ,		
	Vcca Supply Current		1.65V to Vссв	2.3v to 5.5V	Full			2.5			
<b>I</b> CCA			3.6v	0V	Full			2.5	μΑ		
			0v	5.5V	Full			-1			
			1.65V to Vссв	2.3v to 5.5V	Full			10			
Іссв	VccB Supply Current			V <sub>I=</sub> V <sub>O</sub> =open lo=0	3.6v	0V	Full			-1	μA
			0v	5.5V	Full			1	l		
сса + Іссв	Combined Supply Current	V <sub>I</sub> =V <sub>CCI</sub> or GND l <sub>0=</sub> 0	1.65V to Vссв	2.3v to 5.5V	Full			13	μA		
lccza	Vcca Supply Current	V <sub>I</sub> =V <sub>CCI</sub> or 0V l <sub>0</sub> =0, OE=0V	1.65V to V <sub>CCB</sub>	2.3v to 5.5V	Full			1	μA		
lссzв	V <sub>CCB</sub> Supply Current	V <sub>I</sub> =V <sub>CCI</sub> or 0V I <sub>O</sub> =0, OE=0V	2.3v to 3.6V	2.3v to 5.5V	Full			1	μA		
Ci	Input Capacitance	OE	3.3V	3.3V	<b>+25</b> ℃		2.5		PF		
0	Input-to-output Internal	A Port	3.3V	3.3V	<b>+25</b> ℃		5		PF		
Cio	Capacitance	B Port	3.3V	3.3V	+25℃		5		FF		

<sup>(1)</sup> Vccı is the VCC associated with the input port.

<sup>(2)</sup>  $\mbox{\sc Vcco}\,$  is the VCC associated with the output port

<sup>(3)</sup>  $\mbox{\sc V}_{\mbox{\scriptsize CCA}}$  must be less than or equal to  $\mbox{\sc V}_{\mbox{\scriptsize CCB}}.$ 



## **Timing Requirements**

## $V_{\text{CCA}}\text{=}1.8V\!\pm\!0.15V$

		Vccв=2.5V±0.2V	Vccв=3.3V±0.2V	Vссв=5V±0.2V	Unit	
		Тур	Тур	Тур		
Data Rate	Push-pull Driving	21	22	24	Mbps	
Data Nato	Open-drain Driving	n-drain Driving 2		2	IVIDPS	
Pulse Duration(tw)	Push-pull Driving (Data Inputs)	47	45	41	ns	
	Open-drain Driving (Data Inputs)	500	500	500		

### $V_{CCA}=2.5V\pm0.15V$

		V <sub>CCB</sub> =2.5V±0.2V	V <sub>CCB</sub> =3.3V±0.2V	V <sub>CCB</sub> =5V±0.2V	Unit
		Тур	Тур	Тур	
Data Rate	Push-pull Driving	20	22	24	Mbps
Data Nate	Open-drain Driving	2	2	2	IVIDPS
Pulse	Push-pull Driving (Data Inputs)	50	45	41	
Duration(tw)	Open-drain Driving (Data Inputs)	500	500	500	ns

### $V_{\text{CCA}}=3.3V\pm0.15V$

		Vссв=3.3V±0.2V	Vссв=5V±0.2V	Unit
		Тур	Тур	JOHN
Data Rate	Push-pull Driving	23	24	Mbps
Bala Halo	Open-drain Driving	2	2	·VISPO
Pulse Duration(tw)	Push-pull Driving (Data Inputs)	43	41	ns
	Open-drain Driving (Data Inputs)	500	500	



## **Switching Characteristics:Vcc=1.8V±0.15V**

over recommended operating free-air temperature range (unless otherwise noted)

Parameter			Conditions	V <sub>ccB</sub> =2.5V±0.2V	V <sub>ccB</sub> =3.3V±0.2V	V <sub>ccB</sub> =5V±0.2V	Units	
	T drameter		Conditions	Тур	Тур	Тур	Onics	
t <sub>PHL</sub>	Propagation Delay Time	A to B	Push-pull Driving	5.6	5	5	ns	
	High-to-low Output		Open-drain Driving	7.5	7.9	8.3		
tpLH	Propagation Delay Time Iow-to-high Output	A to B	Push-pull Driving	10.0	9.5	9	ns	
4.11			Open-drain Driving	181	170	154	110	
tрнL	Propagation Delay Time	B to A	Push-pull Driving	7	7.1	7.2		
	High-to-low Output		Open-drain Driving	7.6	8.1	9.2	ns	
tрLн	Propagation Delay Time	B to A	Push-pull Driving	7.6	6.9	6	ns	
	low-to-high Output		Open-drain Driving	163	145	118		
ten	Enable Time		OE to A or B	135	159	182	ns	
tdis	Disable Time		OE to A or B	170	174	181	ns	
trA	Input Rise Time	A port	Push-pull Driving	13.4	11.9	10.6	ns	
UA	in pair tass time	rise time	Open-drain Driving	68	66	62	10	
trв	Input Rise Time	B port	Push-pull Driving	13	12	11.6	ns	
uБ	'	rise time	Open-drain Driving	66	65	50	110	
t <sub>fA</sub>	Input Fall Time	Aport fall	Push-pull Driving	5.6	4.7	4.0	ns	
ЧA		time	Open-drain Driving	5.0	5.1	5.2	110	
tғв	Input Fall Time	Bport fall	Push-pull Driving	3.0	3.0	2.9	ns	
ub	time	time	Open-drain Driving	6.1	5.6	4.4	10	
tsk(o)	Skew(time), Output	Cha	nnel-to-Channel Skew	0.5	0.5	0.5	ns	
Max	ximum Data Rate		Push-pull Driving	22	23	24	Mbps	
			Open-drain Driving	2	2	2	WINDO	



## **Switching Characteristics:Vcc=2.5V±0.15V**

over operating free-air temperature range (unless otherwise noted)

Parameter			Conditions		V <sub>ccB</sub> =3.3V±0.2V	V <sub>ccB</sub> =5V±0.2V	Units
	rarameter		Conditions	Тур	Тур	Тур	Onio
tрнь	Propagation Delay Time	A to B	Push-pull Driving	3.5	3.5	3.2	ns
u ne	High-to-low Output	7110 2	Open-drain Driving	6.3	6.5	6.7	110
tецн	Propagation Delay Time	A to B	Push-pull Driving	4.5	4.9	4.7	ns
421	low-to-high Output		Open-drain Driving	158	152	142	
tрнL	Propagation Delay Time High-to-low	B to A	Push-pull Driving	3.7	3.9	4.6	
	Output		Open-drain Driving	6	6.6	7.7	ns
tецн	Propagation Delay Time low-to-high	B to A	Push-pull Driving	4.8	4	2.5	ns
	Output		Open-drain Driving	153	138	116	
ten	Enable Time		OE to A or B		41.8	130	ns
tdis	Disable Time		OE to A or B	175	181	182	ns
trA	Input Rise Time	A port	Push-pull Driving	9.8	8.6	7.5	no
UTA	input ruos rimo	Rise Time	Open-drain Driving	79	77	65	ns
t <sub>гВ</sub>	Input Rise Time	B port	Push-pull Driving	9.8	8.7	8.1	ns
rrB	inpact des time	Rise Time	Open-drain Driving	93	68	53	115
tfA	Input Fall Time	Aport Fall	Push-pull Driving	4.6	4.1	3.6	
UA	inpact all time	Time	Open-drain Driving	5.1	5.1	5.2	ns
tғв	Input Fall Time	Bport Fall	Push-pull Driving	4.5	4.0	4.0	ns
		Time	Open-drain Driving	6.9	7.4	7.8	113
tsk(o)	Skew(time), Output	Cha	nnel-to-Channel Skew	0.5	0.5	0.5	ns
Max	ximum Data Rate		Push-pull Driving	22	24	24	Mbps
		(	Open-drain Driving	2	2	2	



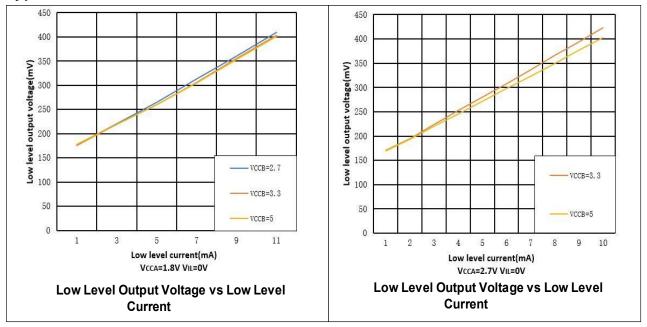
## Switching Characteristics:Vcc=3.3V±0.15V

over recommended operating free-air temperature range (unless otherwise noted)

Parameter		Conditions		V <sub>ccB</sub> =3.3V±0.2V		Units
			Containe		TYP	0
tрнL	Propagation Delay Time High-to-low Output	A to B	Push-pull Driving	2.1	2.2	_ ns
			Open-drain Driving	5.9	6.1	
tрLH	Propagation Delay Time High-to-low Output	A to B	Push-pull Driving	1	3.3	_ ns
			Open-drain Driving	138	131	
t <sub>PHL</sub>	Propagation Delay Time High-to-low Output	B to A	Push-pull Driving	2.3	2.6	ns
			Open-drain Driving	5.4	6.6	
tр⊔н	Propagation delay time low-to-high Output	B to A	Push-pull Driving	1.0	1.0	ns
			Open-drain Driving	133	115	
ten	Enable Time	OE to A or B		4.7	5.2	ns
tdis	Disable Time	OE to A or B		174	182	ns
tra	Input Rise Time	A port Rise Time	Push-pull Driving	7.4	6.6	ns
VА			Open-drain Driving	75	67	
trв	Input Rise Time	B port Rise Time	Push-pull Driving	7.7	7.1	- ns
uъ			Open-drain Driving	70	65	
t <sub>f</sub> A	Input Fall Time	Aport Fall Time	Push-pull Driving	3.4	3.0	- ns
uA			Open-drain Driving	5.1	5.1	
tғв	Input Fall Time	Bport Fall Time	Push-pull Driving	3.5	3.2	ns
us			Open-drain Driving	6.8	6.7	
tsk(o)	Skew(time), Output	Channel-to-Channel Skew		0.5	0.5	ns
Maximum Data Rate		Push-pull Driving		24	24	Mbps
			Open-drain Driving		2	



## **Typical Characteristics**

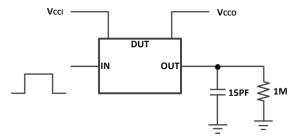


## **Parameter Measurement Information**

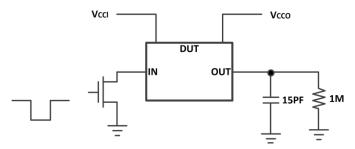
Unless otherwise noted, all input pulsed are supplied by generators having the following characteristics:

- PSRR 10MHz
- Zo=50 Ω
- dv/dt ≥1V/ns

Note: All input pulses are measured one at a time with one transition per measurement



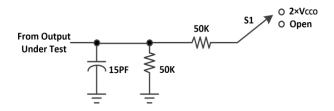
Data Rate, Pulse Duration, Propagation Delay, Output Rise and Fall Time Measurement Using a Push-Pull Driver



Data Rate, Pulse Duration, Propagation Delay, Output Rise and Fall Time Measurement Using an Open-Drain Driver



## **Parameter Measurement Information (Continued)**

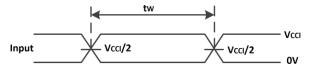


#### Load Circuit for Enable/Disable Time Measurement

Switch Configuration for Enable/Disable Timing

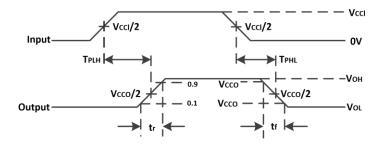
Test	<b>S1</b>	
<b>t</b> <sub>PZL</sub> <sup>(1)</sup> , <b>t</b> <sub>PLZ</sub> <sup>(2)</sup>	2×V <sub>cco</sub>	
t <sub>PHZL</sub> <sup>(1)</sup> , t <sub>PZH</sub> <sup>(2)</sup>	Open	

- (1) t<sub>PZL</sub> and t<sub>PZH</sub> are the same as ten.
- (2) tPLZ and tPHZ are the same as tdis.

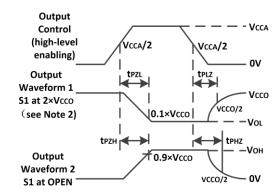


(1) All input pulses are measured one at a time, with one transition per measurement.

#### **Voltage Waveforms Pulse Duration**



### **Voltage Waveforms Propagation Delay Times**



**Voltage Waveforms Enable and Disable** 

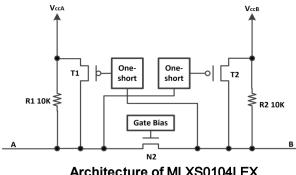


#### Overview

The MLXS0104LEX IC is a Bi-direction voltage-level translator specifically designed for translating logic voltage levels. The A port can accept I/O voltages that cover from 1.65 V to 3.6 V range; The B port can accept I/O voltages from 2 .3 V to 5.5 V. The device is a pass-gate architecture with edge-rate accelerators (one-shots) to improve the overall data rate. 10-kΩ pullup resistors that usually used in open-drain applications have been integrated inside IC with the advantage saving an external resistor. Not only the IC is designed for open-drain applications, but also this device can translate push-pull CMOS logic outputs.

### **Architecture**

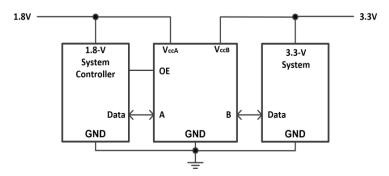
The MLXS0104LEX architecture (see Figure below) is a translator with Bi-direction-Sensing function that means a direction-control mechanism to control the direction of data flow from A to B or from B to A is not needed. These two bidirectional channels independently determine the direction of data flow without a direction-control signal. This auto- direction feature is realized by each I/O pin can be automatically reconfigured as either an input or an output.



Architecture of MLXS0104LEX

## **Application Information**

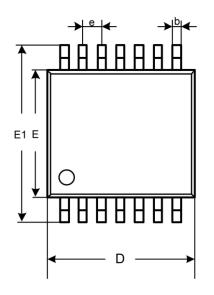
The MLXS0104LEX device can be used to bridge the digital-switching compatibility gap between two voltage nodes to successfully interface logic threshold levels found in electronic systems. It should be used in a point-topoint topology for interfacing devices or systems operating at different interface voltages with one another. Its primary target application use is for interfacing with open-drain drivers on the data I/Os such as I2C or 1-wire, where the data is bidirectional and no control signal is available. The device can also be used in applications where a push-pull driver is connected to the data I/Os, but the MLXS0104LEX might be a better option for such push-pull applications.

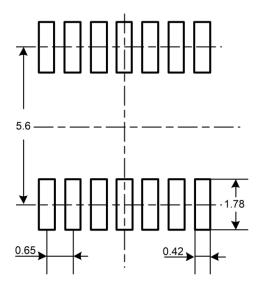


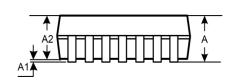
**Typical Application Schematic** 



## **Package Outline Dimension** TSSOP-14









Cumbal	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Min	
A		1.200		0.047	
A1	0.050	0.150	0.002	0.006	
A2	0.800	1.050	0.031	0.041	
b	0.190	0.300	0.007	0.012	
С	0.090	0.200	0.004	0.008	
D	4.860	5.100	0.191	0.201	
E	4.300	4.500	0.169	0.177	
E1	6.250	6.550	0.246	0.258	
е	0.6	0.650BSC		0.026BSC	
L	0.500	0.700	0.020	0.028	
Н	0.2	0.250TYP		0.010TYP	
θ	1°	7°	1°	7°	



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